

Silicon N-Channel Power MOSFET
General Description :

HMM50N120, the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is Sot-227B, which accords with the RoHS standard.

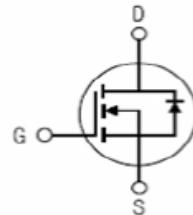
$V_{DSS}(T_c=150^\circ\text{C})$	1200	V
I_D	50	A
$P_D(T_c=25^\circ\text{C})$	700	W
$R_{DS(\text{ON})\text{MAX}}$	280	$\text{m}\Omega$


Features :

- Fast Switching
- ESD Improved Capability
- 100% Single Pulse avalanche energy Test

Applications:

- Power switch circuit of POWER

Absolute ($T_c=25^\circ\text{C}$ unless otherwise specified) :
Inner Equivalent Principium Chart


Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	1200	V
I_D	Continuous Drain Current	50	A
	Continuous Drain Current $T_c=100^\circ\text{C}$	35	A
I_{DM}^{a1}	Pulsed Drain Current(pulse width limited by T_{JM})	200	A
V_{GS}	Gate-to-Source Voltage	± 40	V
E_{AS}	Single Pulse Avalanche Energy	3500	mJ
E_{Ar}^{a1}	Avalanche Energy ,Repetitive	50	mJ
I_{AR}^{a1}	Avalanche Current	50	A
dv/dt^{a2}	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	700	W
	Derating Factor above 25°C	5.7	$\text{W}/^\circ\text{C}$
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	300	$^\circ\text{C}$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

Thermal Characteristics

Symbol	Parameter	Rating			Units
R_{thJC}	Thermal Resistance, Junction-to-Case	0.18			°C/ W
R_{thcs}	Thermal Resistance, Case to heatsink	0.05			°C/ W

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified) :

OFF Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	1200	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}, T_a=25^\circ\text{C}$	--	--	1.0	μA
		$V_{DS}=960\text{V}, V_{GS}=0\text{V}, T_a=125^\circ\text{C}$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	-100	nA

ON Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=15\text{A}$	--	230	280	$\text{m}\Omega$
$V_{GS(\text{TH})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	3.0	--	5.0	V
g_{fs}	Forward Trans conductance	$V_{DS}=15\text{V}, I_D=15\text{A}$	--	18	--	S
Pulse width < 380 μs ; duty cycle < 2%.						

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS}=0\text{V} V_{DS}=25\text{V}$	--	13	--	nF
C_{oss}	Output Capacitance	$f=1.0\text{MHz}$	--	1090	--	pF
C_{rss}	Reverse Transfer Capacitance		--	117	--	

Resistive Switching Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=25\text{A}, V_{DD}=600\text{V}$	--	78	--	ns
t_r	Rise Time		--	68	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	140	--	
t_f	Fall Time		--	72	--	
Q_g	Total Gate Charge	$I_D=25\text{A}, V_{DD}=600\text{V}$	--	480	--	nC
Q_{gs}	Gate to Source Charge		--	88	--	
Q_{gd}	Gate to Drain ("Miller")Charge		--	160	--	

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_{SD}	Continuous Source Current (Body Diode)		--	--	50	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	200	A
V_{SD}	Diode Forward Voltage	$I_S=50A, V_{GS}=0V$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$I_S=50A, T_j=25^\circ C$	--	580	--	ns
Q_{rr}	Reverse Recovery Charge	$dI_F/dt=100A/\mu s, V_{GS}=0V$	--	5.9	--	uC

a1 : Repetitive rating; pulse width limited by maximum junction temperature

a2 : $I_{SD}=30A, dI/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}, \text{ Start } T_j=25^\circ C$